

STP10NK80Z, STP10NK80ZFP, STW10NK80Z

N-channel 800 V, 0.78 Ω 9 A Zener-protected SuperMESH™ Power MOSFETs in TO-220, TO-220FP and TO-247 packages

Datasheet — production data

Features

Туре	V _{DSS}	R _{DS(on)}	I _D	Pw
STP10NK80Z	800V	<0.90Ω	9A	160 W
STP10NK80ZFP	800V	<0.90Ω	9A	40 W
STW10NK80Z	800V	<0.90Ω	9A	160 W

- Extremely high dv/dt capability
- 100% avalanche tested
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeability



Switching application

Description

These devices are N-channel Zener-protected Power MOSFETs developed using STMicroelectronics' SuperMESH™ technology, achieved through optimization of ST's well established strip-based PowerMESH™ layout. In addition to a significant reduction in onresistance, this device is designed to ensure a high level of dv/dt capability for the most demanding applications.

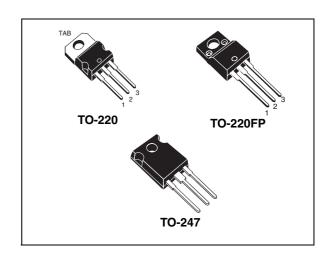


Figure 1. Internal schematic diagram

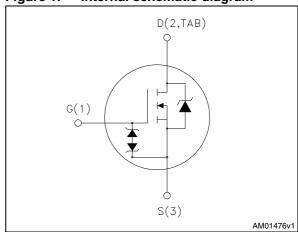


Table 1. Device summary

Part number	Marking	Package	Packaging
STP10NK80Z	P10NK80Z	TO-220	Tube
STP10NK80ZFP	P10NK80ZFP	TO-220FP	Tube
STW10NK80Z	W10NK80Z	TO-247	Tube

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Contents

1	Electrical ratings
2	Electrical characteristics
	2.1 Electrical characteristics (curves)
3	Test circuit
4	Package mechanical data
5	Revision history

1 Electrical ratings

Table 2. Absolute maximum ratings

Counch of	Dougnatou	Value		11
Symbol	Parameter	TO-220/ TO-247	TO-220FP	Unit
V _{DSS}	Drain-source voltage (V _{GS} = 0)	800		V
V _{DGR}	Drain-gate voltage ($R_{GS} = 20k\Omega$)	800		V
V _{GS}	Gate-source voltage	± 30		V
I _D	Drain current (continuous) at T _C = 25°C	9	9 ⁽¹⁾	Α
I _D	Drain current (continuous) at T _C =100°C	6	6 ⁽¹⁾	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	36	36 ⁽¹⁾	Α
P _{TOT}	Total dissipation at T _C = 25°C	160	40	W
	Derating factor	1.28	0.32	W/°C
Vesd(G-S)	G-S ESD (HBM C=100pF, R=1.5kΩ)	4		kV
dv/dt ⁽³⁾	Peak diode recovery voltage slope	4.5		V/ns
V _{ISO}	Insulation withstand voltage (DC)	2500		V
T _J T _{stg}	Operating junction temperature Storage temperature	-55 to 150		°C

- 1. Limited by maximum junction temperature.
- 2. Pulse width limited by safe operating area.
- 3. $I_{SD} \le 9$ A, $di/dt \le 200$ A/ μ s, $V_{DD} \le V_{(BR)DSS}$, $T_j \le T_{JMAX}$

Table 3. Thermal data

Symbol	Parameter		Unit			
Symbol	raiannetei	TO-220	TO-220FP	TO-247	Unit	
R _{thj-case}	Thermal resistance junction-case Max	0.78	3.1	0.78	°C/W	
R _{thj-a}	Thermal resistance junction-ambient Max	62.5		50	°C/W	

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AS}	Avalanche current, repetitive or not-repetitive (pulse width limited by Tj Max)	9	А
E _{AS}	Single pulse avalanche energy (starting Tj=25°C, Id=lar, Vdd=50V)	290	mJ

477

Doc ID 8911 Rev 7

3/17

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 5. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 1$ mA, $V_{GS} = 0$	800			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = 800V V _{DS} = 800V, T _C = 125°C			1 50	μ Α μ Α
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±20V			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 100 \mu A$	3	3.75	4.5	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 4.5A		0.78	0.9	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} = 15V, I_{D} = 4.5A$	-	9.6	-	S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =25V, f=1 MHz, V _{GS} =0	-	2180 205 38	1	pF pF pF
Coss eq ⁽²⁾ .	Equivalent output capacitance	V _{GS} =0, V _{DS} =0V to 640V	-	105	ı	pF
$egin{array}{c} Q_{ m g} \ Q_{ m gd} \end{array}$	Total gate charge Gate-source charge Gate-drain charge	V_{DD} =640V, I_{D} = 9A V_{GS} =10V See <i>Figure 20</i>	-	72 12.5 37	-	nC nC nC

^{1.} Pulsed: pulse duration=300µs, duty cycle 1.5%

^{2.} $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} inceases from 0 to 80% V_{DSS}

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time Rise time	V_{DD} =400 V, I_{D} =4.5A, R_{G} =4.7 Ω , V_{GS} =10V See <i>Figure 21</i>		30 20		ns ns
t _{d(off)}	Turn-off delay Time Fall time	V_{DD} =400 V, I_{D} =4.5A, R_{G} =4.7 Ω , V_{GS} =10V See <i>Figure 21</i>		65 17		ns ns

Table 8. Gate-source zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
BV _{GSO} ⁽¹⁾	Gate-source breakdown voltage	Igs=±1mA (open drain)	30			V

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

Table 9. Source drain diode

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD}	Source-drain current		-		9	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		ı		36	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} =9A, V _{GS} =0	-		1.6	٧
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} =9A, di/dt = 100A/ μ s, V_{DD} =45V, Tj=150°C	-	645 6.4 20		ns μC A

- 1. Pulse width limited by safe operating area
- 2. Pulsed: pulse duration=300µs, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-220 Figure 3. Thermal impedance for TO-220

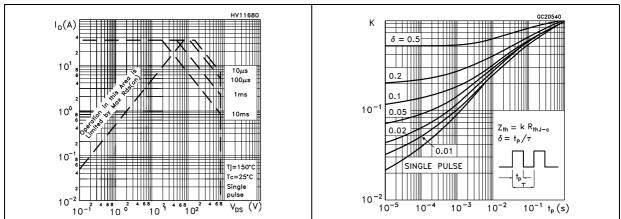


Figure 4. Safe operating area for TO-220FP

Figure 5. Thermal impedance for TO-220FP

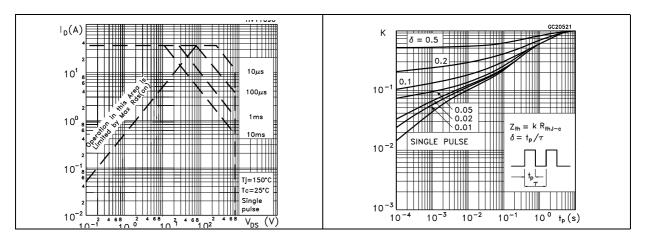


Figure 6. Safe operating area for TO-247

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Figure 7. Thermal impedance for TO-247

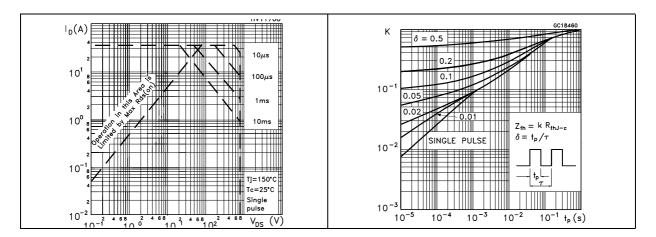
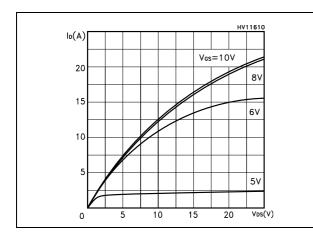


Figure 8. Output characterisics

Figure 9. Transfer characteristics



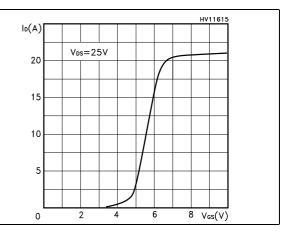
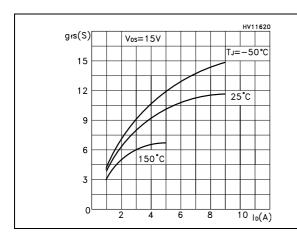


Figure 10. Transconductance

Figure 11. Static drain-source on resistance



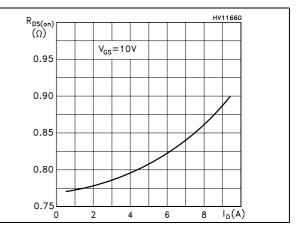
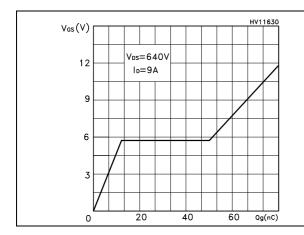
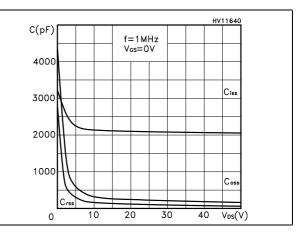


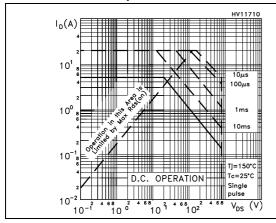
Figure 12. Gate charge vs gate-source voltage Figure 13. Capacitance variations





577

Figure 14. Normalized gate threshold voltage Figure 15. Normalized on resistance vs vs temperature temperature



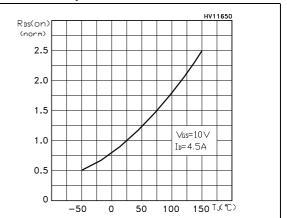
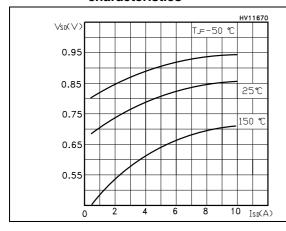


Figure 16. Source-drain diode forward characteristics

Figure 17. Normalized $\mathrm{BV}_{\mathrm{DSS}}$ vs temperature



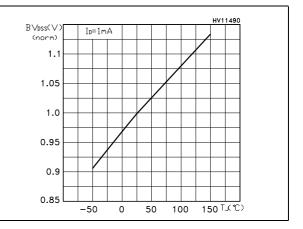
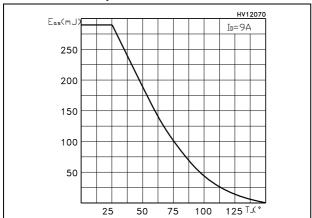


Figure 18. Maximum avalanche energy vs temperature



3 Test circuit

Figure 19. Switching times test circuit for resistive load

Figure 20. Gate charge test circuit

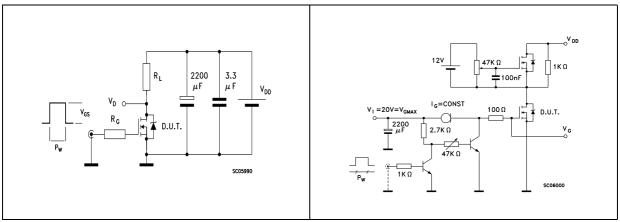


Figure 21. Test circuit for inductive load switching and diode recovery times

Figure 22. Unclamped Inductive load test circuit

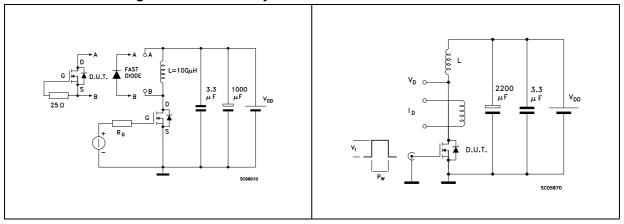
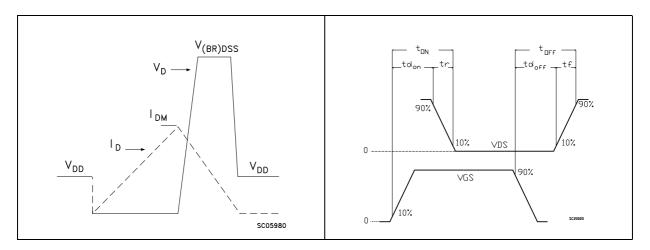


Figure 23. Unclamped inductive waveform

Figure 24. Switching time waveform



577

4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Table 10. TO-220 type A mechanical data

Di	,,	mm					
Dim.	Min.	Тур.	Max.				
А	4.40		4.60				
b	0.61		0.88				
b1	1.14		1.70				
С	0.48		0.70				
D	15.25		15.75				
D1		1.27					
Е	10		10.40				
е	2.40		2.70				
e1	4.95		5.15				
F	1.23		1.32				
H1	6.20		6.60				
J1	2.40		2.72				
L	13		14				
L1	3.50		3.93				
L20		16.40					
L30		28.90					
ØP	3.75		3.85				
Q	2.65		2.95				

D D1 L30 D1 L30

Figure 25. TO-220 type A drawing

5/

Table 11. TO-220FP mechanical data

Dim.	mm		
	Min.	Тур.	Max.
А	4.4		4.6
В	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
Н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

*B* Dia L6 *L2 L7* L3 F1 L4 F2 Ε 7012510_Rev_K_B

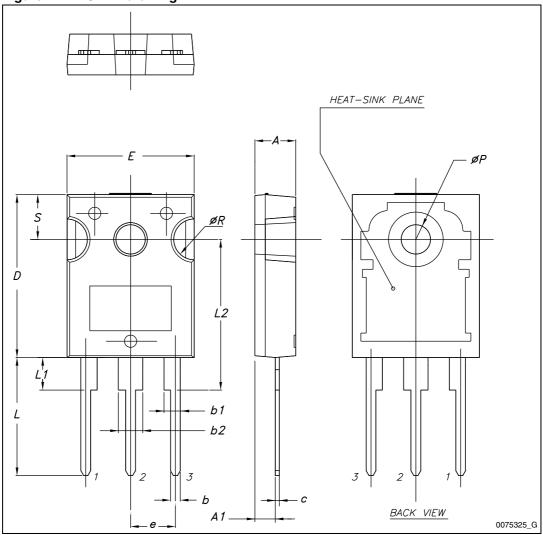
Figure 26. TO-220FP drawing

5/

Table 12. TO-247 mechanical data

Dim.	mm.		
	Min.	Тур.	Max.
А	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
E	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

Figure 27. TO-247 drawing



5 Revision history

Table 13. Document revision history

Date	Revision	Changes
08-Sep-2005	4	Complete document
10-Mar-2006	5	Inserted ecopack indication
28-Sep-2005	6	New template, no content change
15-Mar-2012	7	Content reworked to improve readability. Minor text changes in cover page. Updated Table 5. Updated Section 4: Package mechanical data.

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577

Doc ID 8911 Rev 7 17/17